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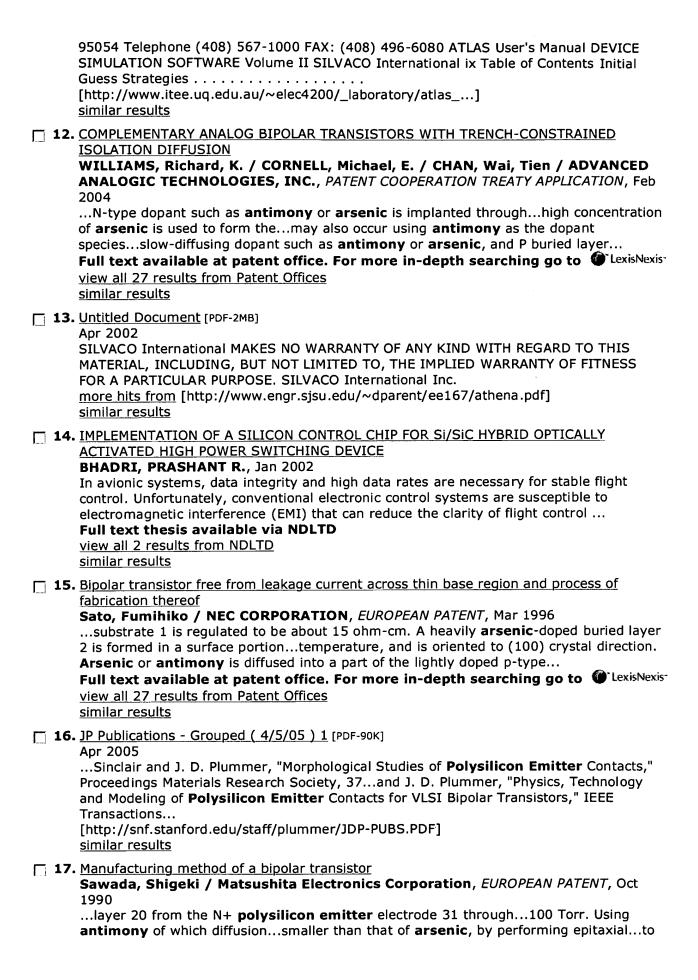
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...vertical isolation. Next, the n-type antimony buried layer for the NPN is implanted...is then implanted with boron and arsenic for the emitter regions. Furnace...implantation and annealing of n (antimony) and p (boron) buried layer, and...

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	21. COMPLEMENTARY BIPOLAR POLYSILICON EMITTER DEVICES ROBINSON, Derek, W. / KRIEGER, William, A. / MARTINEZ, Andre, M. / McDEVITT, Marion, R. / ANALOG DEVICES, INC., PATENT COOPERATION TREATY APPLICATION, Aug 1993 i - 1° COMPLEMENTARY BIPOLAR POLYSILICON EMITTER DEVICES Field of the Invention The present inventione., buried collector) 44, is formed by N-type (e.g.,	"pc ant We quo and ess
	arsenic, antimony, or phosphorous) ion implantation (doping). Then, an Full text available at patent office. For more in-depth searching go to view all 27 results from Patent Offices similar results	Re us foi
***************************************	22. STRUCTURE AND FABRICATION OF BIPOLAR TRANSISTORS BULUCEA, Constantin / GRUBISICH, Michael, J. / NATIONAL SEMICONDUCTOR CORPORATION, EUROPEAN PATENT, Aug 1996layer 12. In the device of Fig. 1, n+ emitter 18, which is formed by dopant outdiffusion from n+ polycrystalline silicon ("polysilicon") emitter contact 20 so as to be self-aligned to emitter contact 20, overlies p intrinsic base 22. The transistor has two	ba: bip bip de: do:
	extrinsic Full text available at patent office. For more in-depth searching go to view all 27 results from Patent Offices similar results	em
	23. USE OF OBLIQUE IMPLANTATION IN FORMING EMITTER OF BIPOLAR TRANSISTOR CHEN, Hung-Sheng / TENG, Chih, Sieh / NATIONAL SEMICONDUCTOR CORPORATION, PATENT COOPERATION TREATY APPLICATION, Jul 1997collector contact zone 24, and polysilicon emitter contact 36. N- emitter extensionof opening 40. See Fig. 3c. Arsenic is then introduced through26, must be done before the arsenic doping employed in creatingdiffuses considerably faster than arsenic. Any high-temperature operation Full text available at patent office. For more in-depth searching go to view all 27 results from Patent Offices similar results	Or
	24. A PROCESS FOR MANUFACTURING IC-COMPONENTS TO BE USED AT RADIO FREQUENCIES NORSTRÖ (M. Hans / NYGREN, Stafan / TYLSTERT, Ola /	Al

TELEFONAKTIEBOLAGET LM ERICSSON, PATENT COOPERATION TREATY APPLICATION, Jan 1999

...constituted of for example an ion implanted layer of **arsenic** or **antimony**, is lithographically defined, after which an epitaxial...surface of the plate. This layer is implanted with **arsenic** in order to become type N+ and will after annealing...

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PROFILE AND PROCESS FOR MANUFACTURING THE SAME
GRUBISICH, Mike / BULUCEA, Constantin / NATIONAL SEMICONDUCTOR
CORPORATION, PATENT COOPERATION TREATY APPLICATION, Jul 1997
...buried n+ collector layer 44 along the substrate/epi interface, and field-isolation region
46 of the trench type. N+ polysilicon emitter contact 48 contacts n+ emitter 50 in a
self-aligned manner. The transistor further includes p base layer 52, a pair of...
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...layer 12. In the device of Fig. 1, n+ emitter 18, which is formed by dopant outdiffusion from n+ polycrystalline silicon ("polysilicon") emitter contact 20 so as to be self-aligned to emitter contact 20, overlies p intrinsic base 22. The transistor has two extrinsic...

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27. Bipolar transistor and photoelectric conversion apparatus using the same
Morishita, Masakazu / CANON KABUSHIKI KAISHA, EUROPEAN PATENT, Oct 1990
...formed between a polysilicon emitter region and a monocrystalline...formed between a polysilicon emitter region and a monocrystalline...phosphorus (Ph), antimony (Sb) or arsenic or p type obtained...present between a polysilicon emitter region and a monocrystalline...

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28. Fabricating a semiconductor structure

Akcasu, Osman Ersed / FAIRCHILD SEMICONDUCTOR CORPORATION, EUROPEAN PATENT, Dec 1988

...preferred embodiment, region 12 is doped with **arsenic** to a concentration of approximately 1...sup6] atoms per cubic centimeter of **arsenic** or phosphorus. Next, and not shown in...should be also thick enough to mask the **arsenic** implant for self-aligned p-n junction...

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29. <u>Ion implantation to increase emitter energy gap in bipolar transistors</u>
Anand, Kranti / Strain, Robert J. / FAIRCHILD SEMICONDUCTOR CORPORATION,
EUROPEAN PATENT, Jan 1986

...the base to the adjacent **polysilicon emitter** of a bipolar transistor...includes the step of doping the **polysilicon emitter** region with oxygen thereby...donor impurity, such as **arsenic** or **antimony**, are implanted into a region...

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view all 27 results from Patent Offices similar results 30. Method for manufacturing a BI-CMOS device Ogura, Seiki / Rovedo, Nivo / International Business Machines Corporation, EUROPEAN PATENT, Jun 1990 ...without masking, and arsenic implant in predetermined...Self-Aligned Narrow Width Polysilicon-Emitter Transistors of an...phosphorous as well as arsenic in the N+ source/drain...an arsenic (As) or antimony (Sb) implant in the...both cases. Now the polysilicon emitter and FET gate electrodes... Full text available at patent office. For more in-depth searching go to LexisNexis view all 27 results from Patent Offices similar results **31.** Method for fabricating a bipolar transistor Pollock, Larry Joseph / Brown, George William / SYNERGY SEMICONDUCTOR CORPORATION, EUROPEAN PATENT, Oct 1989 ...material is formed using arsenic or antimony as the dopant. This buried...simultaneously form the polysilicon emitter and collector contacts 52...preferred embodiment, the polysilicon emitter 52 is deposited over the... Full text available at patent office. For more in-depth searching go to LexisNexisview all 27 results from Patent Offices similar results 32. METHOD OF MANUFACTURING HIGH PERFORMANCE BIPOLAR TRANSISTORS IN A **BICMOS PROCESS** DARMAWAN, Johan, A. / NATIONAL SEMICONDUCTOR CORPORATION, EUROPEAN PATENT, Jul 1996 ...the tapering of the foot of the polysilicon emitter, is controlled when the polysilicon...for a bipolar transistor having a polysilicon emitter adjacent to silicon substrate. Etching...Bipolar transistor 360 includes a polysilicon emitter 310 adjacently overlying substrate... Full text available at patent office. For more in-depth searching go to **CexisNexis** view all 27 results from Patent Offices similar results 33. Narrow band gap base heterojunction bipolar transistors using SiGe alloys Iyer, S.S. / Patton, G.L. / Harame, D.L. / Stork, J.M.C. / Crabbe, E.F. / Meyerson, B.S., Thin Solid Films, Jan 1990 ...deposited epitaxially without breaking vacuum. Antimony and gallium were used during the deposition as...of Si/SiGe junctions was produced by diffusing arsenic from a polysilicon emitter into an epitaxially deposited base. Silicon and... Published journal article available from *CIENCE @DIRECT similar results 34. Semiconductor bipolar device and method of manufacturing the same Ishigaki, Yoshiyuki / Honda, Hiroki / Uga,Kimiharu / Ishida, Masahiro / MITSUBISHI DENKI KABUSHIKI KAISHA, EUROPEAN PATENT, Apr 1995 ...polycrystalline silicon doped with arsenic (As). Emitter electrode 515...polycrystalline silicon doped with arsenic. The surface of interconnection...as a mask, impurity such as antimony (Sb) is implanted into p...563. Referring to Fig. 79, arsenic is implanted into the whole... Full text available at patent office. For more in-depth searching go to CexisNexisview all 27 results from Patent Offices similar results 35. METHOD OF MANUFACTURING HIGH PERFORMANCE BIPOLAR TRANSISTORS IN A **BICMOS PROCESS** DARMAWAN, Johan, A. / NATIONAL SEMICONDUCTOR CORPORATION, PATENT

COOPERATION TREATY APPLICATION, Feb 1996

...tapering of the foot of the polysilicon emitter, is controlled when the...bipolar transistor having a polysilicon emitter adjacent to silicon substrate...equal to the thickness of polysilicon emitter 310 and thin polysilicon...exemplary BiCMOS process, n' antimony implant layers may be buried... Full text available at patent office. For more in-depth searching go to LexisNexisview all 27 results from Patent Offices similar results **36.** Bipolar transistor process using sidewall spacer for aligning base insert Colinge, Jean-Pierre / Hewlett-Packard Company, EUROPEAN PATENT, Aug 1989 ...steps of: forming a polysilicon emitter contact pedestal on...chemically removed. A heavy arsenic, or other n-type dopant such as antimony, implant penetrates...5A, including the polysilicon emitter contact pedestal 204... Full text available at patent office. For more in-depth searching go to CExisNexisview all 27 results from Patent Offices similar results ☐ 37. A VLSI self-aligned bipolar transistor Brighton, Jeffrey E. / TEXAS INSTRUMENTS INCORPORATED, EUROPEAN PATENT. Jan 1988 ...base region is self-aligned to a polysilicon emitter and which defines the emitter region...thermally oxidizing the edge of the N+ polysilicon emitter which makes junction depth control...transistor structure in which a doped polysilicon emitter contact, used to form a self-aligned... Full text available at patent office. For more in-depth searching go to CexisNexis* view all 27 results from Patent Offices similar results **38.** Semiconductor transistor Morishita, Masakazu / Sugawa, Shigetoshi / Koizumi, Toru / CANON KABUSHIKI KAISHA, EUROPEAN PATENT, Mar 1994 ...emitter and the case of forming a bipolar transistor of a polysilicon emitter are shown, respectively. As will be understood from Fig...process. In case of forming a bipolar transistor of a polysilicon emitter, six masks are added to the standard CMOS process. Consequently... Full text available at patent office. For more in-depth searching go to **LexisNexis** view all 27 results from Patent Offices similar results ☐ 39. Integrated bipolar and CMOS transistor fabrication process Shah, Rajiv R. / Tran, Toan / TEXAS INSTRUMENTS INCORPORATED, EUROPEAN PATENT, Aug 1988 ...defining CMOS transistor gate conductors and the bipolar polysilicon emitter region. The heavily doped thick polysilicon forms the...bipolar transistor. In forming the walled emitter, the polysilicon emitter is in contact with the transition region between the field... Full text available at patent office. For more in-depth searching go to LexisNexisview all 27 results from Patent Offices similar results **40.** Method for producing a buried contact Schottky logic array, and device produced thereby Morris, Francis J. / Evans, Stephen A. / TEXAS INSTRUMENTS INCORPORATED, EUROPEAN PATENT, Jun 1987 ...patterned and heavily implanted with arsenic to make them N-type. Layer 45 is then...The poly layer 45 may be implanted with arsenic and annealed before it is patterned. The anneal diffuses the arsenic out of the polysilicon bodies 46 and... Full text available at patent office. For more in-depth searching go to LexisNexisview all 27 results from Patent Offices similar results

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☐ 41. Method for producing a poly emitter logic array, and device produced thereby Morris, Francis J. / Evans, Stephen A. / TEXAS INSTRUMENTS INCORPORATED,	You "pc ant We quo and ess
view all 27 results from Patent Offices similar results 42. Semiconductor integreated circuit device and method of manufacturing the same Iwasaki, Hiroshi / KABUSHIKI KAISHA TOSHIBA, EUROPEAN PATENT, Sep 1986semiconductor device described above, arsenic is doped in a polysiliconby diffusion from the doped polysilicon emitter electrode. EP-A-0 03 43 41an N-type impurity such as antimony (Sb) is diffused into theprocess shown in Fig. 1E, arsenic is doped in regions 29, 30	Re us for bar bip bip
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43. An improved twin-well BiCMOS process Eklund, Robert H. / Havemann, Robert H. / Haken, Roger A. / Scott, David B. / TEXAS INSTRUMENTS INCORPORATED, EUROPEAN PATENT, Jun 1989 diffusion of dopant from the polysilicon emitter contact which makes contactby making contact to the polysilicon emitter electrode at a locationis typically required for antimony diffusion. The resultantcourse other dopants such as arsenic may be used to form buried	em epi fiel inp int
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44. A bicmos process for forming self-aligned NPN emitters and bases and mosfet/source drains Havemann, Robert H. / TEXAS INSTRUMENTS INCORPORATED, EUROPEAN PATENT, Dec 1988 defined in the substrat and then a deped polysilican emitter and poly gates are	Or Al

9	formed in the bipolarformed by implanting an impurity such as antimony into the substrate with a dose of aboutimplanted with n-type impurity such as arsenic at a dosage of approximately 1.0 x 10
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